


<b>Search Notes</b>  	<b>Application/Control No.</b>  10711030	<b>Applicant(s)/Patent Under Reexamination</b>  BOSSEN ET AL.
	<b>Examiner</b>  HIEP NGUYEN	<b>Art Unit</b>  3686

SEARCHED			
Class	Subclass	Date	Examiner
705	04	4/20/2009	HN
706	40, 45, and 50	4/20/2009	HN

SEARCH NOTES		
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Search EAST- See attached search history	4/20/2009	HN
Reviewed and considered EIC3600 template search results	5/5/2010	HN

INTERFERENCE SEARCH			
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Examiner, Art Unit 3686